74F269 8-bit bidirectional binary counter Rev. 05 – 25 March 2010

Product data sheet

1. General description

The 74F269 is a fully synchronous 8-stage up/down counter featuring a preset capability for programmable operation, carry look-ahead for easy cascading and a U/\overline{D} input to control the direction of counting. All state changes, whether in counting or parallel loading, are initiated by the rising edge of the clock.

2. Features and benefits

- Synchronous counting and loading
- Built-in look-ahead carry capability
- Count frequency 115 MHz (typical)
- Supply current 95 mA (typical)

3. Ordering information

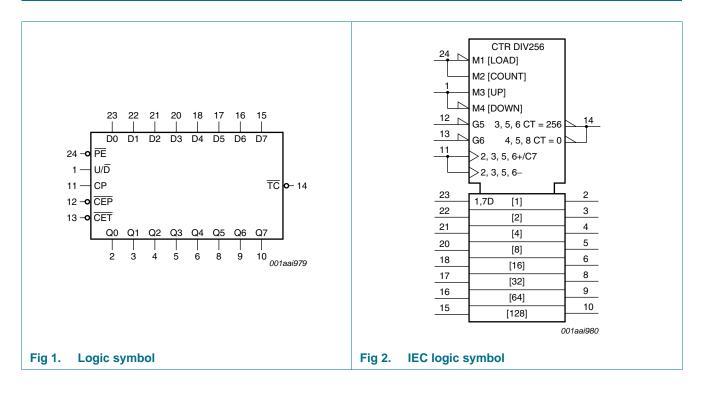
Table 1.Ordering information

Type number	Package								
	Temperature range	Name	Description	Version					
N74F269D	0 °C to 70 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1					
N74F269DB	0 °C to 70 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1					

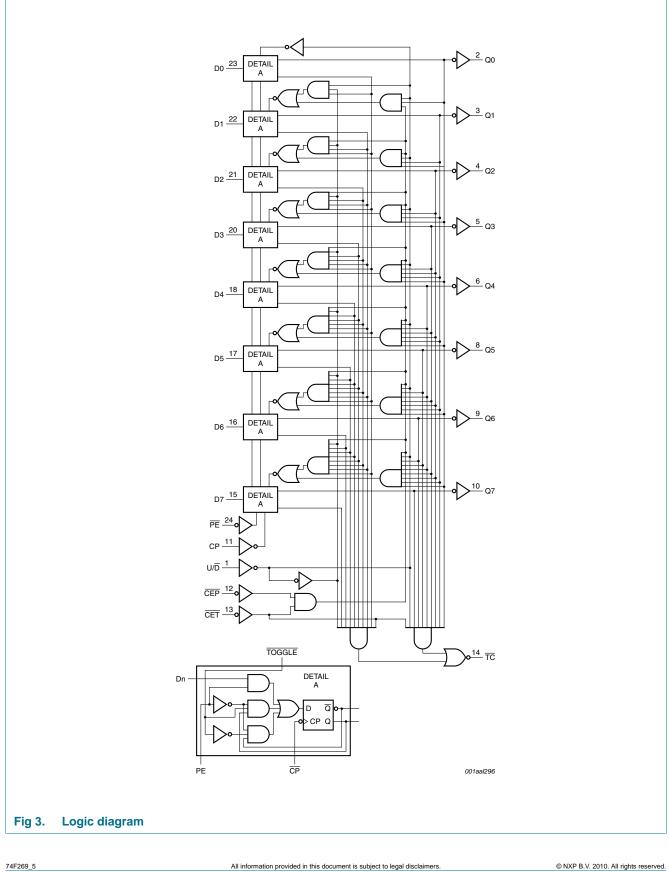


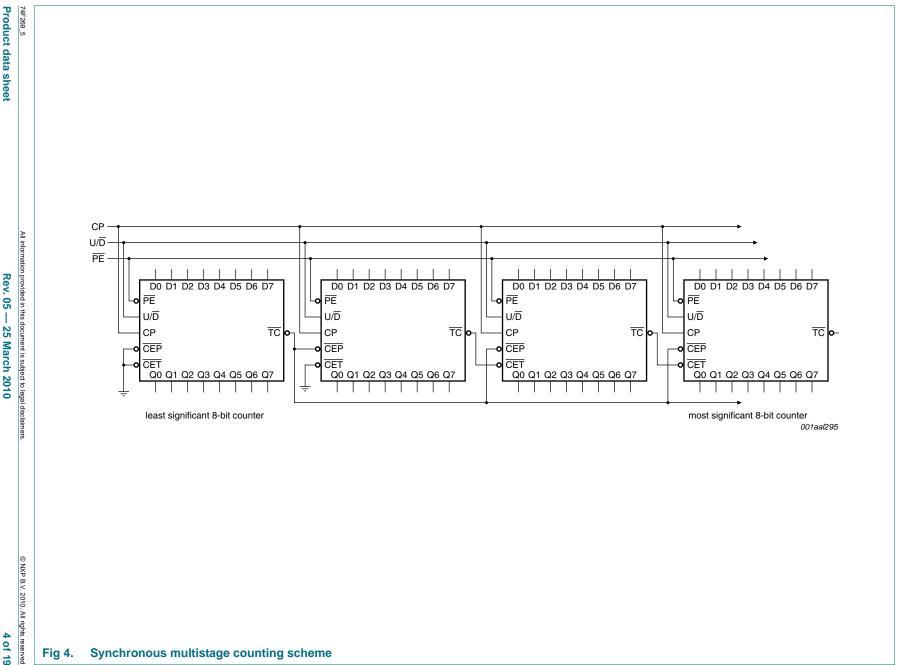
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4. Functional diagram



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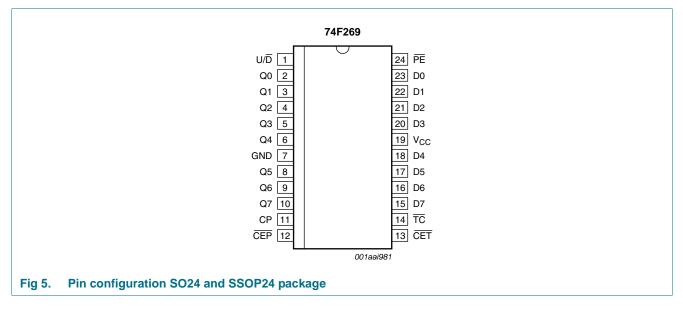
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5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2.Pin description

Symbol	Pin	Description	Unit load HIGH/LOW	Load value ^[1] HIGH/LOW
U/D	1	up or down count control input	1.0/1.0	20 µA/0.6 mA
Q0 to Q7	2, 3, 4, 5, 6, 8, 9, 10	data output	50/33	1.0 mA/20 mA
GND	7	ground (0 V)	-	-
СР	11	clock input	1.0/1.0	20 µA/0.6 mA
CEP	12	count enable parallel input (active LOW)	1.0/1.0	20 µA/0.6 mA
CET	13	count enable trickle input (active LOW)	1.0/1.0	20 µA/0.6 mA
TC	14	terminal count output (active LOW)	50/33	1.0 mA/20 mA
D0 to D7	23, 22, 21, 20, 18, 17, 16, 15	data input	1.0/1.0	20 µA/0.6 mA
V _{CC}	19	supply voltage	-	-
PE	24	parallel enable input (active LOW)	1.0/1.0	20 µA/0.6 mA

[1] One FAST Unit Load (UL) is defined as 20 μA in HIGH state, 0.6 μA in LOW state.

6. Functional description

6.1 Function table

Table 3. Function table^[1]

Operating modes	Input		Output	Output				
	СР	U/D	CEP	CET	PE	Dn	Qn	тс
Parallel load (Dn to Qn)	↑	Х	Х	Х	I	I	L	*
	\uparrow	Х	Х	Х	I	h	Н	*
Count up (increment)	↑	h	I	I	h	Х	count up	*
Count down (decrement)	↑	I	I	I	h	Х	count down	*
Hold (do nothing)	\uparrow	Х	h	I	h	Х	qn	*
	\uparrow	Х	Х	h	h	Х	qn	Н

[1] H = HIGH voltage level steady state

h=HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition

L = LOW voltage level steady state

I = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition

qn = Lower case letters indicate state of referenced output prior to the LOW-to-HIGH clock transition

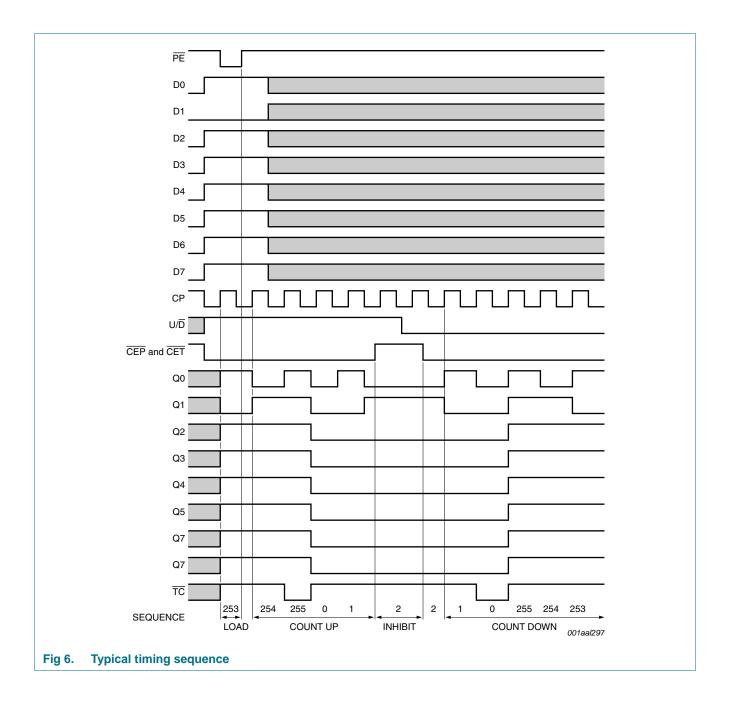
X = don't care

 \uparrow = LOW-to-HIGH clock transition

* = The $\overline{\text{TC}}$ is LOW when $\overline{\text{CET}}$ is LOW and the counter is at terminal count

Terminal count up is with all Qn outputs HIGH and terminal count down is with all Qn outputs LOW.

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7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –0.5	+7.0	V
Vo	output voltage	output in HIGH-state	<u>[1]</u> –0.5	+5.5	V
I _{IK}	input clamping current	V ₁ < 0 V	-30	+5	mA
lo	output current	output in LOW-state	-	40	mA
T _{amb}	ambient temperature	in free air	[2] 0	70	°C
T _{stg}	storage temperature		-65	+150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

8. Recommended operating conditions

Table 5.	Recommended	operating	conditions
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SymbolParameterConditionsMinTypMaxUnit V_{CC} supply voltage4.55.05.5V V_{IH} HIGH-level input voltage2.0V V_{IL} LOW-level input voltage-6.8V I_{IK} input clamping current18mA I_{OH} HIGH-level output current-1-2.0mA I_{OL} LOW-level output current18mA									
	Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
V_{IL} LOW-level input voltage0.8V I_{IK} input clamping current18mA I_{OH} HIGH-level output current-1mA	V _{CC}	supply voltage		4.5	5.0	5.5	V		
I_{IK} input clamping current18mA I_{OH} HIGH-level output current-1mA I_{OH} LOW/level autput current-1mA	V _{IH}	HIGH-level input voltage		2.0	-	-	V		
I _{OH} HIGH-level output current -1 - mA	V _{IL}	LOW-level input voltage		-	-	0.8	V		
	I _{IK}	input clamping current		-	-	-18	mA		
I _{OL} LOW-level output current 20 mA	I _{OH}	HIGH-level output current		–1	-	-	mA		
	I _{OL}	LOW-level output current		-	-	20	mA		

9. Static characteristics

Symbol	Parameter	Conditions		25 °C			–40 °C to +85 °C		Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	-
V _{IK}	input clamping voltage	$V_{CC} = 4.5 \text{ V}; \text{ I}_{IK} = -18 \text{ mA}$		-1.2	-0.73	-	-1.2	-	V
V _{OH}	HIGH-level output	V_{CC} = 4.5 V; V_{I} = V_{IL} or V_{IH}							
	voltage	$V_{CC} = \pm 10$ %; $I_{OH} = -1$ mA		-	-	-	2.5	-	V
		$V_{CC} = \pm 5$ %; $I_{OH} = -1$ mA		-	3.4	-	2.7	-	V
V _{OL}	LOW-level output voltage	$\label{eq:V_CC} \begin{array}{l} V_{CC} = 4.5 \ V; \ I_{OL} = 20 \ mA; \\ V_{I} = V_{IL} \ or \ V_{IH} \end{array}$							
		V _{CC} = ±10 %		-	0.30	-	-	0.50	V
		$V_{CC} = \pm 5 \%$		-	0.30	-	-	0.50	V
l _l	input leakage current	$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = 7.0 \text{ V}$		-	-	-	-	100	μΑ
I _{IH}	HIGH-level input current	$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = 2.7 \text{ V}$		-	-	-	-	20	μΑ
IIL	LOW-level input current	$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = 0.5 \text{ V}$		-	-	-	-	-0.6	mA
lo	output current	$V_{CC} = 5.5 V$	[2]	-	-	-	-60	-150	mA
I _{CC}	supply current	$\overline{PE} = \overline{CET} = \overline{CEP} = U/\overline{D} = GND;$ V _{CC} = 5.5 V; CP = rising edge							
		Dn: V _I = 4.5 V		-	93	-	-	120	mA
		Dn: V _I = GND		-	98	-	-	125	mΑ

Table 6. Static characteristics

[1] All typical values are measured at V_{CC} = 5 V.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

10. Dynamic characteristics

Table 7.Dynamic characteristics

GND = 0 V; for test circuit, see <u>Figure 13</u>.

Symbol	Parameter	Conditions		25 °C; V _{CC} = 5.0 V			0 °C to 70 °C; V _{CC} = 5.0 V \pm 0.5 V	
				Тур	Max	Min	Max	
t _{PLH}	LOW to HIGH	CP to Qn; load; \overline{PE} = LOW; see Figure 7	3.0	6.0	8.5	3.0	9.0	ns
	propagation delay	CP to Qn; count; \overline{PE} = HIGH; see Figure 7	3.0	6.0	9.0	3.0	10.0	ns
		CP to TC; see Figure 7	4.5	6.5	9.5	4.0	10.5	ns
		CET to TC; see Figure 8	3.5	6.0	9.0	3.0	10.0	ns
		U/D to TC; see Figure 9	4.5	7.0	9.0	4.0	10.0	ns
t _{PHL}	HIGH to LOW	CP to Qn; load; \overline{PE} = LOW; see Figure 7	4.0	6.5	8.5	4.0	9.0	ns
	propagation delay	CP to Qn; count; \overline{PE} = HIGH; see <u>Figure 7</u>	4.5	7.0	10.0	4.0	10.5	ns
		CP to TC; see Figure 7	5.0	6.5	9.5	5.0	10.0	ns
		CET to TC; see Figure 8	3.0	6.5	9.0	3.0	10.0	ns
		U/D to TC; see Figure 9	4.5	7.0	9.5	4.0	10.0	ns

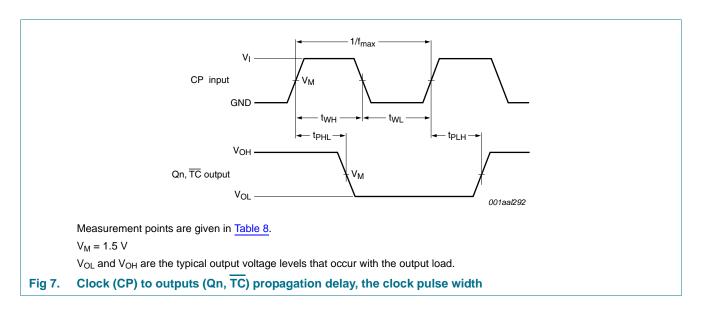
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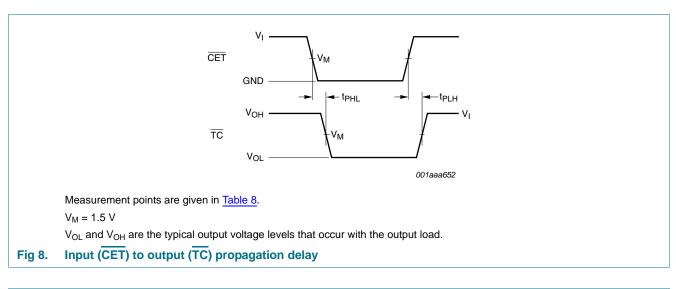
Symbol	Parameter	Conditions		V _{CC} =	5.0 V	0 °C to 70 °C; V _{CC} = 5.0 V \pm 0.5 V		Unit
			Min	Тур	Max	Min	Max	
t _{su(H)}	set-up time HIGH	Dn to CP; see Figure 10	3.5	-	-	2.5	-	ns
		PE to CP; see Figure 10	5.5	-	-	5.5	-	ns
		CEP or CET to CP; see Figure 11	6.0	-	-	5.0	-	ns
		U/\overline{D} to CP; see Figure 12	8.0	-	-	6.5	-	ns
t _{su(L)} s	set-up time LOW	Dn to CP; see Figure 10	3.5	-	-	2.5	-	ns
		PE to CP; see Figure 10	6.5	-	-	6.5	-	ns
		CEP or CET to CP; see Figure 11	8.0	-	-	6.5	-	ns
		U/D to CP; see Figure 12	6.5	-	-	6.5	-	ns
t _{h(H)}	hold time HIGH	Dn to CP; see Figure 10	1.0	-	-	0	-	ns
		PE to CP; see Figure 10	0	-	-	0	-	ns
		CEP or CET to CP; see Figure 11	0	-	-	0	-	ns
		U/D to CP; see Figure 12	0	-	-	0	-	ns
t _{h(L)}	hold time LOW	Dn to CP; see Figure 10	1.0	-	-	1.0	-	ns
		PE to CP; see Figure 10	0	-	-	0	-	ns
		CEP or CET to CP; see Figure 11	0	-	-	0	-	ns
		U/\overline{D} to CP; see Figure 12	0	-	-	0	-	ns
t _{WH}	pulse width HIGH	CP; see Figure 7	4.0	-	-	4.0	-	ns
t _{WL}	pulse width LOW	CP; see Figure 7	4.5	-	-	5.0	-	ns
f _{max}	maximum frequency	see <u>Figure 7</u>	100	115	-	85	-	MHz

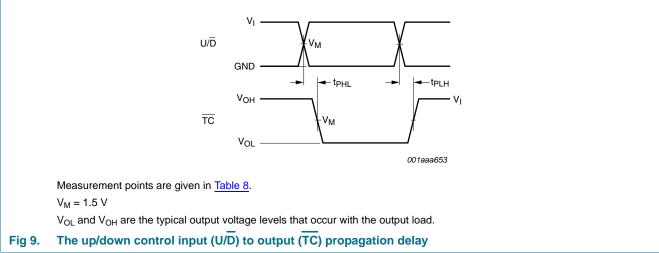
Table 7.Dynamic characteristics ... continuedGND = 0 V; for test circuit, see Figure 13.

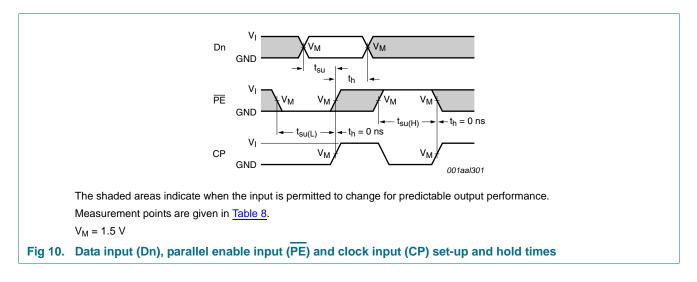
11. Waveforms



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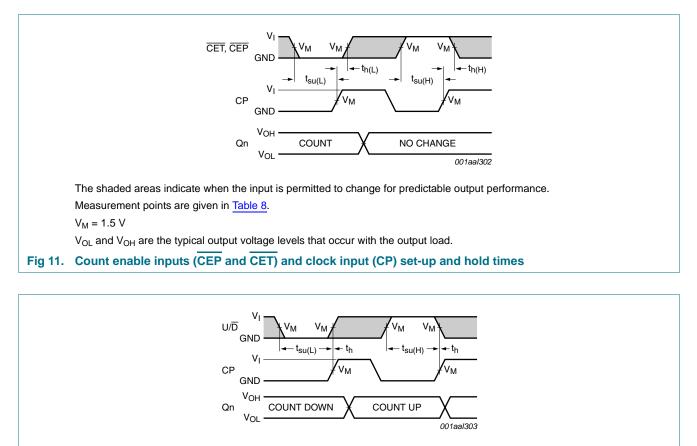






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The shaded areas indicate when the input is permitted to change for predictable output performance. Measurement points are given in <u>Table 8</u>. $V_{12} = 1.5 V_{12}$

 $V_{M} = 1.5 V$

 V_{OL} and V_{OH} are the typical output voltage levels that occur with the output load.

Fig 12. Up/down count control input (U/D) and clock input (CP) set-up and hold times

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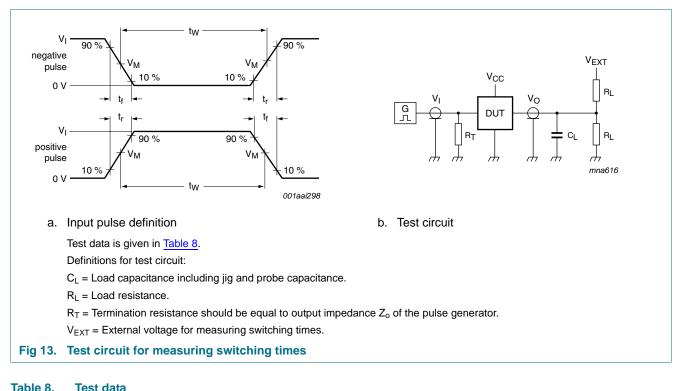


Table 0.	Test uata								
Input					Load		V _{EXT}		
VI	fı	tw	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}	
3.0 V	1 MHz	500 ns	\leq 2.5 ns	50 pF	500 Ω	open	open	7.0 V	

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12. Package outline

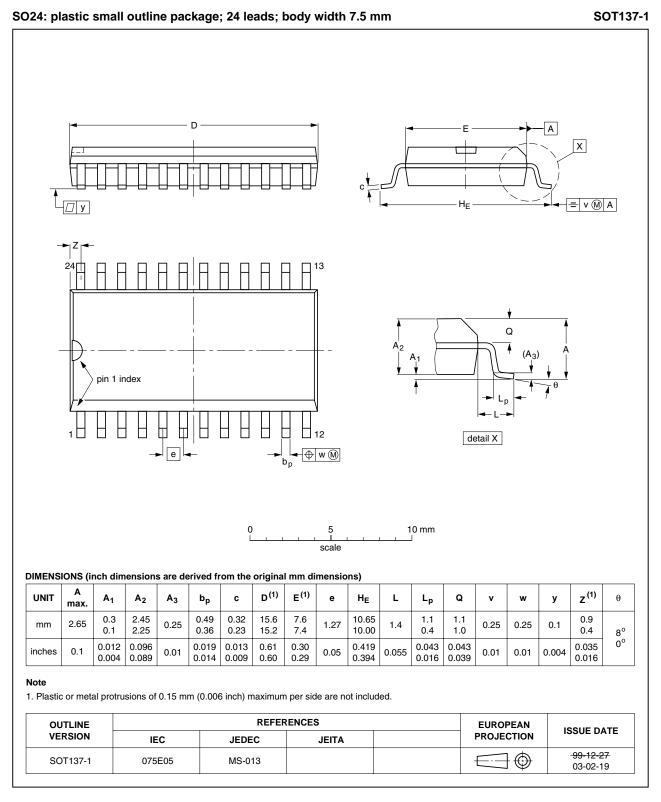


Fig 14. Package outline SOT137-1 (SO24)

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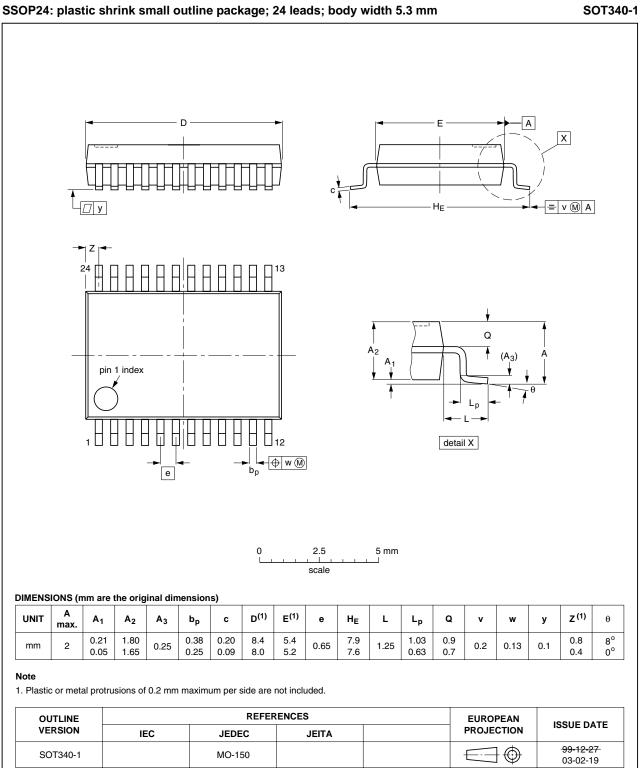


Fig 15. Package outline SOT340-1 (SSOP24)

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13. Abbreviations

Table 9.	Abbreviations
Acronym	Description
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model

14. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
74F269_5	20100325	Product data sheet	-	74F269_4				
74F269_4	20100308	Product data sheet	-	74F269_3				
Modifications:	: <u>Table 6 "Static characteristics"</u> : Conditions typical values corrected.							
74F269_3	20100126	Product data sheet	-	74F269_2				
Modifications:		of this data sheet has been of NXP Semiconductors.	redesigned to comply v	vith the new identity				
	 Legal texts have been adapted to the new company name where appropriate. 							
		T222-1) package removed t "Package outline"	from Section 3 "Orderin	g information" and				
74F269_2	19960105	Product specification	-	74F269_1				

15. Legal information

15.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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